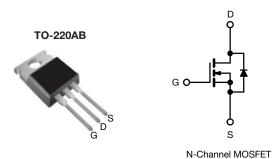


# **Power MOSFET**



| PRODUCT SUMMAI           | RY                     |     |
|--------------------------|------------------------|-----|
| V <sub>DS</sub> (V)      | 80                     | 00  |
| $R_{DS(on)}(\Omega)$     | V <sub>GS</sub> = 10 V | 3.0 |
| Q <sub>g</sub> max. (nC) | 7                      | 8   |
| Q <sub>gs</sub> (nC)     | 9.                     | .6  |
| Q <sub>gd</sub> (nC)     | 4                      | 5   |
| Configuration            | Sin                    | gle |

### **FEATURES**

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <a href="https://www.vishay.com/doc?99912"><u>www.vishay.com/doc?99912</u></a>

#### Note

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

## **DESCRIPTION**

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

| ORDERING INFORMATION            |                |
|---------------------------------|----------------|
| Package                         | TO-220AB       |
| Lead (Pb)-free                  | IRFBE30PbF     |
| Lead (Pb)-free and halogen-free | IRFBE30PbF-BE3 |

| PARAMETER   |                         |   | SYMBOL          | LIMIT | UNIT     |  |
|---|-------------------------|---|-----------------|-------|----------|--|
| Drain-source voltage                                    |                         | V <sub>DS</sub>                                   | 800             |       |          |  |
| Gate-source voltage                                     |                         |   | V <sub>GS</sub> | ± 20  | V        |  |
| Continuous drain current                                | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 25 °C<br>T <sub>C</sub> = 100 °C |                 | 4.1   | А        |  |
| Continuous drain current                                |                         | T <sub>C</sub> = 100 °C                           | I <sub>D</sub>  | 2.6   |          |  |
| Pulsed drain current <sup>a</sup>                       |                         | I <sub>DM</sub>                                   | 16              |       |          |  |
| Linear derating factor                                  |                         |   | 1.0             | W/°C  |          |  |
| Single pulse avalanche energy b                         |                         | E <sub>AS</sub>                                   | 260             | mJ    |          |  |
| Repetitive avalanche current a                          |                         | I <sub>AR</sub>                                   | 4.1             | Α     |          |  |
| Repetitive avalanche energy <sup>a</sup>                |                         | E <sub>AR</sub>                                   | 13              | mJ    |          |  |
| Maximum power dissipation $T_C = 25  ^{\circ}C$         |                         | P <sub>D</sub>                                    | 125             | W     |          |  |
| Peak diode recovery dV/dt <sup>c</sup>                  |                         |   | dV/dt           | 2.0   | V/ns     |  |
| Operating junction and storage temperature range        |                         | T <sub>J</sub> , T <sub>stg</sub>                 | -55 to +150     | °C    |          |  |
| Soldering recommendations (peak temperature) d For 10 s |                         |   | 300             |       |          |  |
| Mounting torque   | 6-32 or M3 screw        |   |                 | 10    | lbf ⋅ in |  |
| Mounting torque   |                         |   |                 | 1.1   | N⋅m      |  |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 29 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 4.1 A (see fig. 12)
- c.  $I_{SD} \le 4.1$  A,  $dI/dt \le 100$  A/ $\mu$ s,  $V_{DD} \le 600$ ,  $T_J \le 150$  °C
- d. 1.6 mm from case



# Vishay Siliconix

| THERMAL RESISTANCE RAT              | INGS              |      |      |      |
|-------------------------------------|-------------------|------|------|------|
| PARAMETER                           | SYMBOL            | TYP. | MAX. | UNIT |
| Maximum junction-to-ambient         | R <sub>thJA</sub> | -    | 62   |      |
| Case-to-sink, flat, greased surface | R <sub>thCS</sub> | 0.50 | -    | °C/W |
| Maximum junction-to-case (drain)    | R <sub>thJC</sub> | -    | 1.0  |      |

| PARAMETER                                 | SYMBOL                | TEST CONDITIONS   |   | MIN.       | TYP.      | MAX.                 | UNIT             |
|---|-----------------------|---|---|------------|-----------|----------------------|------------------|
| Static                                    |                       |   |   |            |           |                      |                  |
| Drain-source breakdown voltage            | $V_{DS}$              | $V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$   |   | 800        | -         | -                    | V                |
| V <sub>DS</sub> temperature coefficient   | $\Delta V_{DS}/T_{J}$ | Reference to 25 °C, I <sub>D</sub> = 1 mA   |   | -          | 0.9       | -                    | V/°C             |
| Gate-source threshold voltage             | V <sub>GS(th)</sub>   | V <sub>DS</sub> =   | V <sub>GS</sub> , I <sub>D</sub> = 250 μA                                       | 2.0        | -         | 4.0                  | V                |
| Gate-source leakage                       | I <sub>GSS</sub>      | V   | <sub>GS</sub> = ± 20 V  | -          | -         | ± 100                | nA               |
| <b>7</b>                                  |                       | $V_{DS} =$  | 800 V, V <sub>GS</sub> = 0 V  | -          | -         | 100                  | μА               |
| Zero gate voltage drain current           | I <sub>DSS</sub>      | $V_{DS} = 640 \text{ V},$   | V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                                  | -          | -         | 500                  |                  |
| Drain-source on-state resistance          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 2.5 A <sup>b</sup>   | -          | -         | 3.0                  | Ω                |
| Forward transconductance                  | 9 <sub>fs</sub>       | V <sub>DS</sub> = 1   | 100 V, I <sub>D</sub> = 2.5 A <sup>b</sup>                                      | 2.5        | -         | -                    | S                |
| Dynamic                                   |                       |   |   |            |           |                      |                  |
| Input capacitance                         | C <sub>iss</sub>      | $V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$      |   | -          | 1300      | -                    | pF               |
| Output capacitance                        | C <sub>oss</sub>      |   |   | -          | 310       | -                    |                  |
| Reverse transfer capacitance              | C <sub>rss</sub>      |   |   | -          | 190       | -                    |                  |
| Total gate charge                         | Qg                    |   |   | -          | -         | 78                   |                  |
| Gate-source charge                        | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 4.1 A, V <sub>DS</sub> = 400 V, see fig. 6 and 13 <sup>b</sup> | -          | -         | 9.6                  | nC               |
| Gate-drain charge                         | Q <sub>gd</sub>       | 1   |   | -          | -         | 45                   |                  |
| Turn-on delay time                        | t <sub>d(on)</sub>    |   |   | -          | 12        | -                    |                  |
| Rise time                                 | t <sub>r</sub>        | V <sub>DD</sub> = 400 V, I <sub>D</sub> = 4.1 A   |   | -          | 33        | -                    | ns               |
| Turn-off delay time                       | t <sub>d(off)</sub>   | $R_g = 12 \Omega$ , F   | $R_g = 12 \Omega$ , $R_D = 95 \Omega$ , see fig. 10 b                           |            | 82        | -                    |                  |
| Fall time                                 | t <sub>f</sub>        |   |   | -          | 30        | -                    |                  |
| Gate input resistance                     | R <sub>g</sub>        | f = 1 MHz, open drain   |   | 0.6        |           | 1.6                  | Ω                |
| Internal drain inductance                 | L <sub>D</sub>        | 6 mm (0.25")  | Between lead,<br>6 mm (0.25") from  |            | 4.5       | -                    | 211              |
| Internal source inductance                | L <sub>S</sub>        | package and center of die contact   |   | -          | 7.5       | -                    | - nH             |
| Drain-Source Body Diode Characteristic    | cs                    |   |   |            |           |                      |                  |
| Continuous source-drain diode current     | I <sub>S</sub>        | showing t   | MOSFET symbol showing the   |            | -         | 4.1                  | A                |
| Pulsed diode forward current <sup>a</sup> | I <sub>SM</sub>       | integral reverse p - n junction diode   |   | -          | -         | 16                   | A                |
| Body diode voltage                        | V <sub>SD</sub>       | $T_J = 25  ^{\circ}\text{C},  I_S = 4.1  \text{A},  V_{GS} = 0  \text{V}^{ \text{b}}$           |   | -          | -         | 1.8                  | V                |
| Body diode reverse recovery time          | t <sub>rr</sub>       | T 05 %C 1   | 4.4.4. dl/d+ 400.4/h  | -          | 480       | 720                  | ns               |
| Body diode reverse recovery charge        | Q <sub>rr</sub>       | $T_J = 25  ^{\circ}\text{C}, I_F = 4.1  \text{A}, dI/dt = 100  \text{A/}\mu\text{s}^{\text{b}}$ |   | -          | 1.8       | 2.7                  | μC               |
| Forward turn-on time                      | t <sub>on</sub>       | Intrinsic tur   | n-on time is negligible (turn   | -on is dor | ninated b | y L <sub>S</sub> and | L <sub>D</sub> ) |

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width  $\leq 300~\mu s;~duty~cycle \leq 2~\%$



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

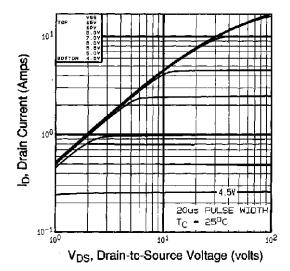


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

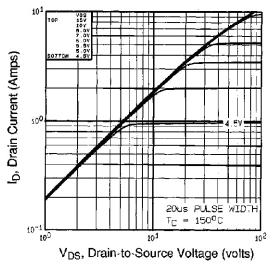
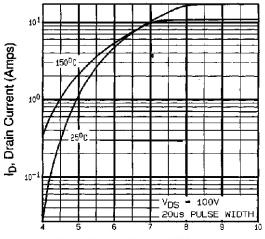


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C



V<sub>GS</sub>, Gate-to-Source Voltage (volts)

Fig. 3 - Typical Transfer Characteristics

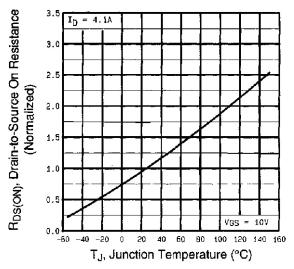


Fig. 4 - Normalized On-Resistance vs. Temperature



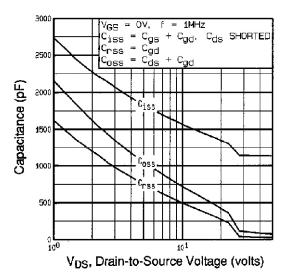


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

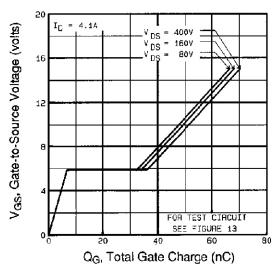


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

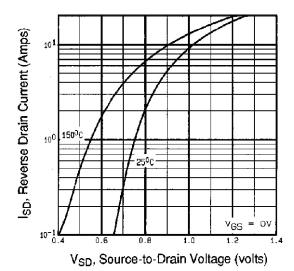


Fig. 7 - Typical Source-Drain Diode Forward Voltage

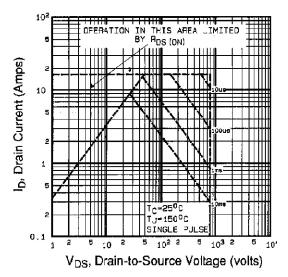


Fig. 8 - Maximum Safe Operating Area



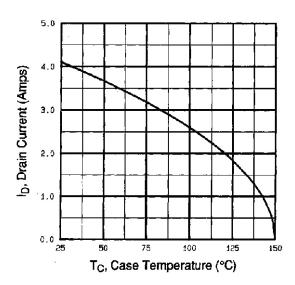


Fig. 9 - Maximum Drain Current vs. Case Temperature

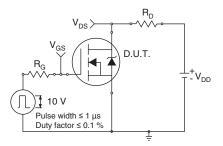


Fig. 10a - Switching Time Test Circuit

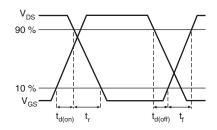


Fig. 10b - Switching Time Waveforms

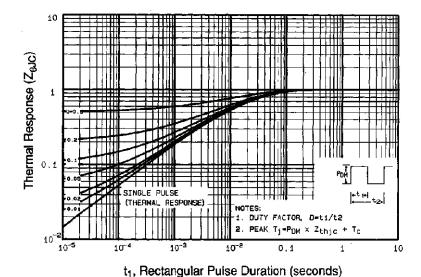


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

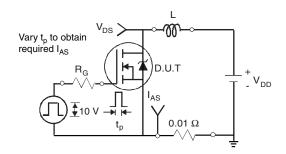


Fig. 12a - Unclamped Inductive Test Circuit

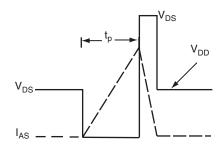


Fig. 12b - Unclamped Inductive Waveforms



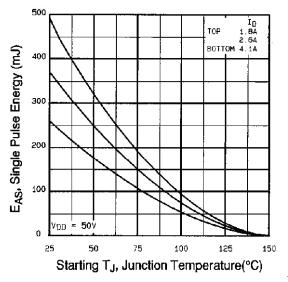


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

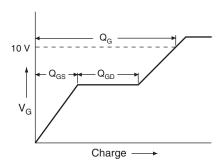


Fig. 13a - Basic Gate Charge Waveform

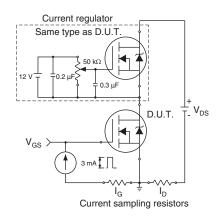
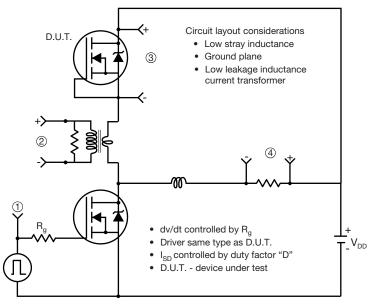


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dv/dt Test Circuit



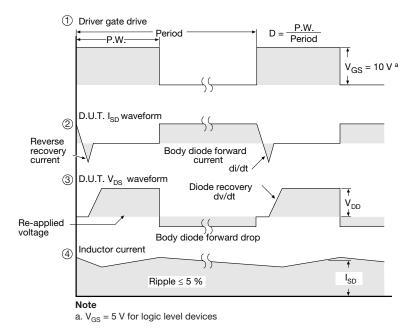


Fig. 14 - For N-Channel

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# TO-220-1



| DIM. | MILLIM | METERS | INCHES |       |
|------|--------|--------|--------|-------|
|      | MIN.   | MAX.   | MIN.   | MAX.  |
| Α    | 4.24   | 4.65   | 0.167  | 0.183 |
| b    | 0.69   | 1.02   | 0.027  | 0.040 |
| b(1) | 1.14   | 1.78   | 0.045  | 0.070 |
| С    | 0.36   | 0.61   | 0.014  | 0.024 |
| D    | 14.33  | 15.85  | 0.564  | 0.624 |
| Е    | 9.96   | 10.52  | 0.392  | 0.414 |
| е    | 2.41   | 2.67   | 0.095  | 0.105 |
| e(1) | 4.88   | 5.28   | 0.192  | 0.208 |
| F    | 1.14   | 1.40   | 0.045  | 0.055 |
| H(1) | 6.10   | 6.71   | 0.240  | 0.264 |
| J(1) | 2.41   | 2.92   | 0.095  | 0.115 |
| L    | 13.36  | 14.40  | 0.526  | 0.567 |
| L(1) | 3.33   | 4.04   | 0.131  | 0.159 |
| ØP   | 3.53   | 3.94   | 0.139  | 0.155 |
| Q    | 2.54   | 3.00   | 0.100  | 0.118 |

## Note

DWG: 6031

•  $M^* = 0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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